

Search Notes

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Examiner

Drew E. Becker

Applicant(s)/Patent under
Reexamination

YOKOO ET AL.

Art Unit

1761

SEARCHED

Class	Subclass	Date	Examiner
search	patented	1-19-07	DEB

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR